

Notice of References Cited	Application/Control No. 09/501,114	Applicant(s)/Patent Under Reexamination TZENG, YONHUA	
	Examiner Wesley D Markham	Art Unit 1762	Pag 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,624,719	04-1997	Tanabe et al.	427/577
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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